

Notice of References Cited	Application/Control No. 10/765,043		Applicant(s)/Patent Under Reexamination MARUYAMA ET AL.	
	Examiner UMAR CHEEMA		Art Unit 2144	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,911,044 A	06-1999	Lo et al.	709/203
*	B	US-2001/0021037 A1	09-2001	Itoh, Shin-Ichi	358/1.15
*	C	US-6,292,271 B1	09-2001	Phan, Tom	358/440
*	D	US-2002/0080398 A1	06-2002	Matsushima, Hiroyuki	358/1.15
*	E	US-2002/0107983 A1	08-2002	Iyoki, Yutaka	709/245
*	F	US-2003/0145200 A1	07-2003	Eden, Guy	713/161
*	G	US-2004/0021889 A1	02-2004	McAfee et al.	358/1.13
*	H	US-6,710,893 B1	03-2004	Hou et al.	358/1.15
*	I	US-7,024,486 B2	04-2006	Itoh, Shin-Ichi	709/238
*	J	US-7,124,201 B2	10-2006	Iyoki, Yutaka	709/245
*	K	US-7,327,480 B1	02-2008	Ida et al.	358/1.15
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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